

Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|---|--------------------------------------|------|-------|------|---------------------|--|
| $V_{(\text{BR})\text{DSS}}$ | Drain-to-Source Breakdown Voltage | 55 | — | — | V | $V_{GS} = 0V, I_D = 250\mu\text{A}$ |
| $\Delta V_{(\text{BR})\text{DSS}}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | — | 0.053 | — | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$ |
| $R_{\text{DS}(\text{on})}$ | Static Drain-to-Source On-Resistance | — | 11 | 13.5 | m Ω | $V_{GS} = 10\text{V}, I_D = 36\text{A}$ ③ |
| | | — | — | 20 | | $V_{GS} = 5.0\text{V}, I_D = 30\text{A}$ ③ |
| | | — | — | 22.5 | | $V_{GS} = 4.5\text{V}, I_D = 15\text{A}$ ③ |
| $V_{GS(\text{th})}$ | Gate Threshold Voltage | 1.0 | — | 3.0 | V | $V_{DS} = V_{GS}, I_D = 250\mu\text{A}$ |
| g_{fs} | Forward Trans conductance | 25 | — | — | S | $V_{DS} = 25\text{V}, I_D = 36\text{A}$ ③ |
| I_{DSS} | Drain-to-Source Leakage Current | — | — | 20 | μA | $V_{DS} = 55\text{V}, V_{GS} = 0\text{V}$ |
| | | — | — | 250 | | $V_{DS} = 55\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$ |
| I_{GSS} | Gate-to-Source Forward Leakage | — | — | 200 | nA | $V_{GS} = 16\text{V}$ |
| | Gate-to-Source Reverse Leakage | — | — | -200 | | $V_{GS} = -16\text{V}$ |

Dynamic Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| | | | | | | |
|-----------------|------------------------------|---|------|----|----|---|
| Q_g | Total Gate Charge | — | 23 | 35 | nC | $I_D = 36\text{A}$ $V_{DS} = 44\text{V}$ $V_{GS} = 5.0\text{V}$ ③ |
| Q_{gs} | Gate-to-Source Charge | — | 8.5 | — | | |
| Q_{gd} | Gate-to-Drain Charge | — | 12 | — | | |
| $t_{d(on)}$ | Turn-On Delay Time | — | 14 | — | ns | $V_{DD} = 28\text{V}$ $I_D = 36\text{A}$ |
| t_r | Rise Time | — | 130 | — | | $R_G = 15\Omega$ |
| $t_{d(off)}$ | Turn-Off Delay Time | — | 24 | — | | $V_{GS} = 5.0\text{V}$ ③ |
| t_f | Fall Time | — | 33 | — | | |
| L_D | Internal Drain Inductance | — | 4.5 | — | nH | Between lead, 6mm (0.25in.) from package and center of die contact |
| L_S | Internal Source Inductance | — | 7.5 | — | | |
| C_{iss} | Input Capacitance | — | 1570 | — | | |
| C_{oss} | Output Capacitance | — | 230 | — | pF | $V_{GS} = 0\text{V}$ $V_{DS} = 25\text{V}$ $f = 1.0\text{MHz}$ |
| C_{rss} | Reverse Transfer Capacitance | — | 130 | — | | |
| C_{oss} | Output Capacitance | — | 840 | — | | $V_{GS} = 0\text{V}, V_{DS} = 1.0\text{V}$ $f = 1.0\text{MHz}$ |
| C_{oss} | Output Capacitance | — | 180 | — | | $V_{GS} = 0\text{V}, V_{DS} = 44\text{V}$ $f = 1.0\text{MHz}$ |
| $C_{oss\ eff.}$ | Effective Output Capacitance | — | 290 | — | | $V_{GS} = 0\text{V}, V_{DS} = 0\text{V to } 44\text{V}$ ④ |

Diode Characteristics

| | Parameter | Min. | Typ. | Max. | Units | Conditions |
|----------|---|---|------|------|-------|--|
| I_s | Continuous Source Current (Body Diode) | — | — | 42 | A | MOSFET symbol showing the integral reverse p-n junction diode. |
| I_{sM} | Pulsed Source Current (Body Diode) ① | — | — | 240 | | |
| V_{SD} | Diode Forward Voltage | — | — | 1.3 | V | $T_J = 25^\circ\text{C}, I_s = 36\text{A}, V_{GS} = 0\text{V}$ ③ |
| t_{rr} | Reverse Recovery Time | — | 22 | 33 | | $T_J = 25^\circ\text{C}, I_F = 36\text{A}, V_{DD} = 28\text{V}$ $di/dt = 100\text{A}/\mu\text{s}$ ③ |
| Q_{rr} | Reverse Recovery Charge | — | 14 | 21 | nC | |
| t_{on} | Forward Turn-On Time | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$) | | | | |

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by $T_{J\max}$, starting $T_J = 25^\circ\text{C}$, $L = 0.089\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 36\text{A}$, $V_{GS} = 10\text{V}$. Part not recommended for use above this value.
- ③ Pulse width $\leq 1.0\text{ms}$; duty cycle $\leq 2\%$.
- ④ $C_{oss\ eff.}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}
- ⑤ Limited by $T_{J\max}$, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑥ This value determined from sample failure population, starting $T_J = 25^\circ\text{C}$, $L = 0.089\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 36\text{A}$, $V_{GS} = 10\text{V}$.
- ⑦ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- ⑧ R_θ is measured at T_J approximately 90°C .

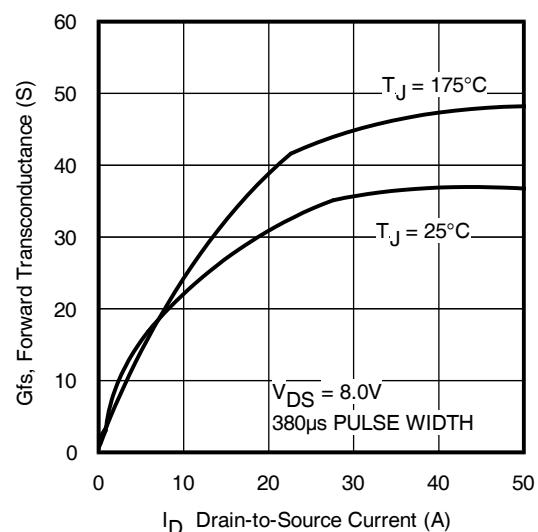
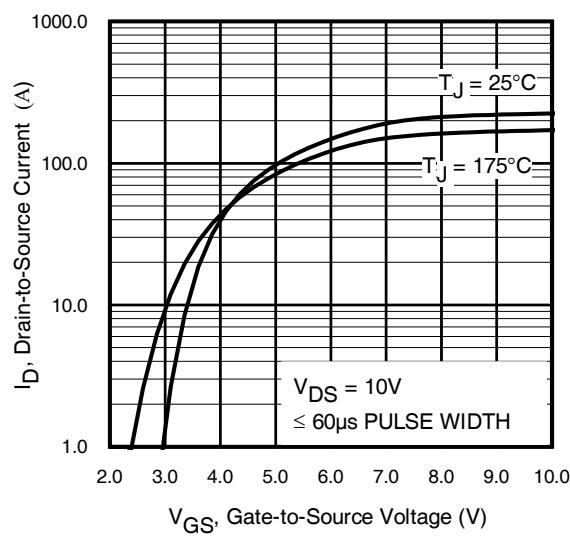
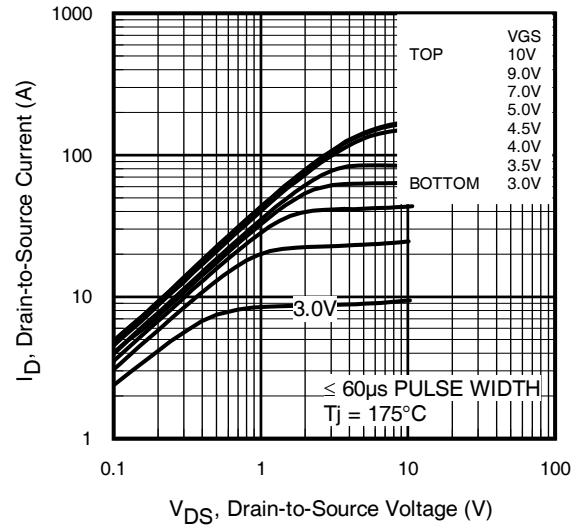
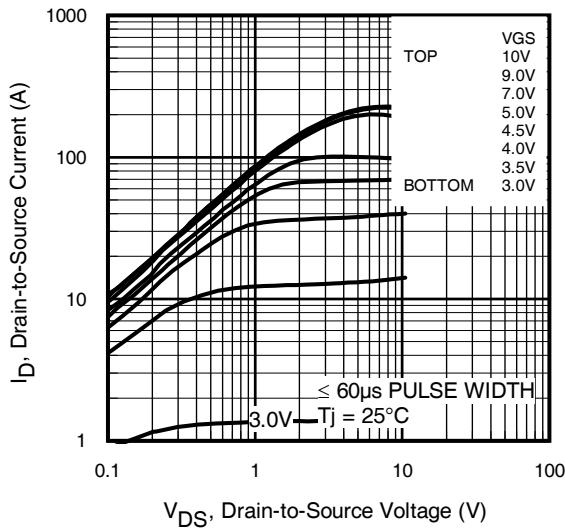


Fig. 3 Typical Transfer Characteristics

Fig. 4 Typical Forward Transconductance Vs. Drain Current

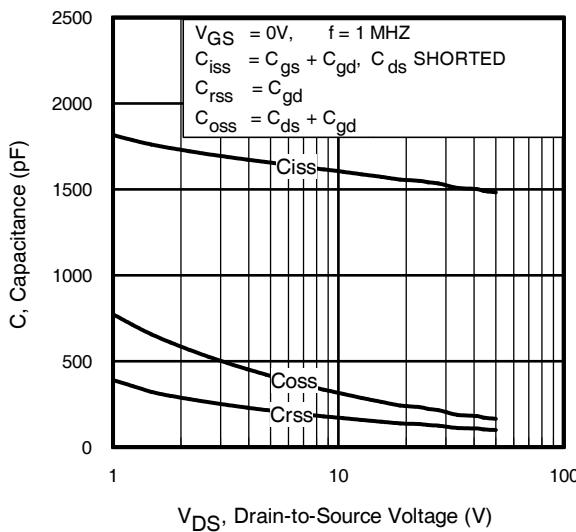


Fig 5. Typical Capacitance vs.
Drain-to-Source Voltage

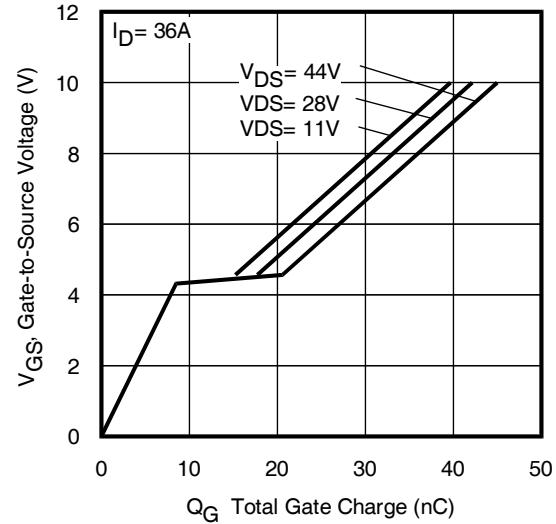


Fig 6. Typical Gate Charge vs.
Gate-to-Source Voltage

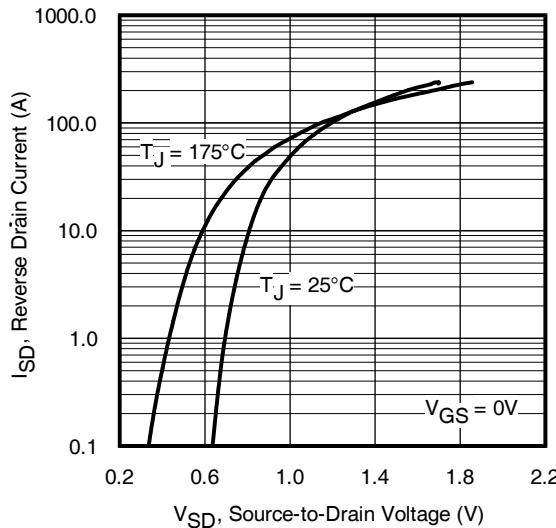


Fig. 7 Typical Source-to-Drain Diode
Forward Voltage

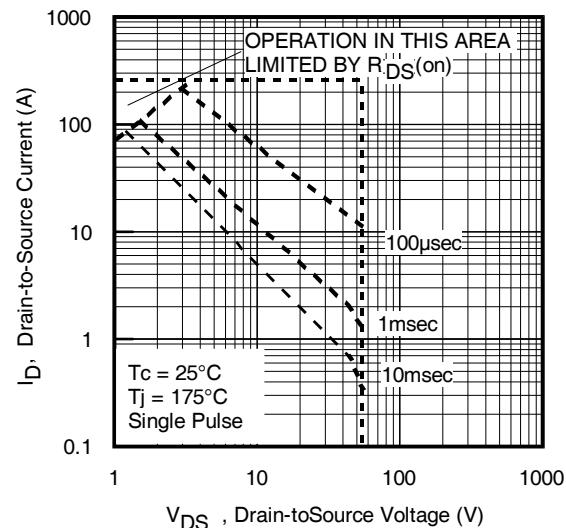


Fig. 8. Maximum Safe Operating Area

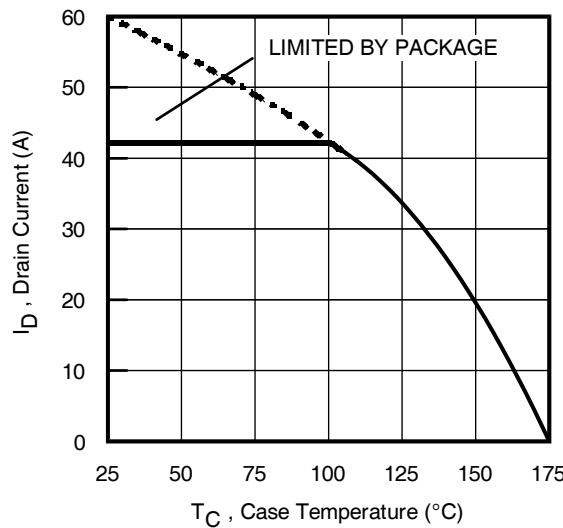


Fig 9. Maximum Drain Current Vs. Case Temperature

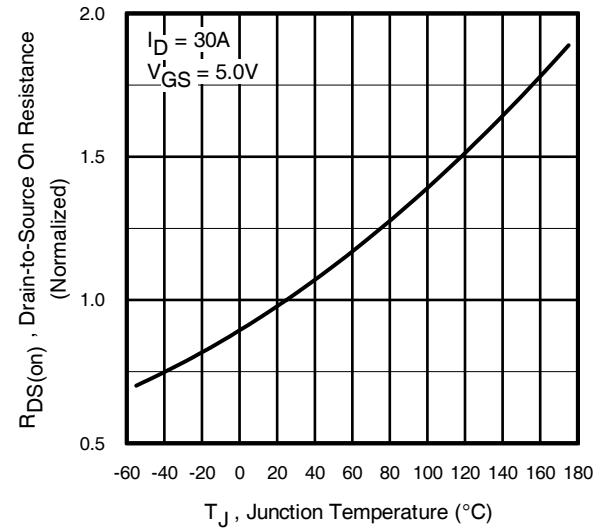


Fig 10. Normalized On-Resistance Vs. Temperature

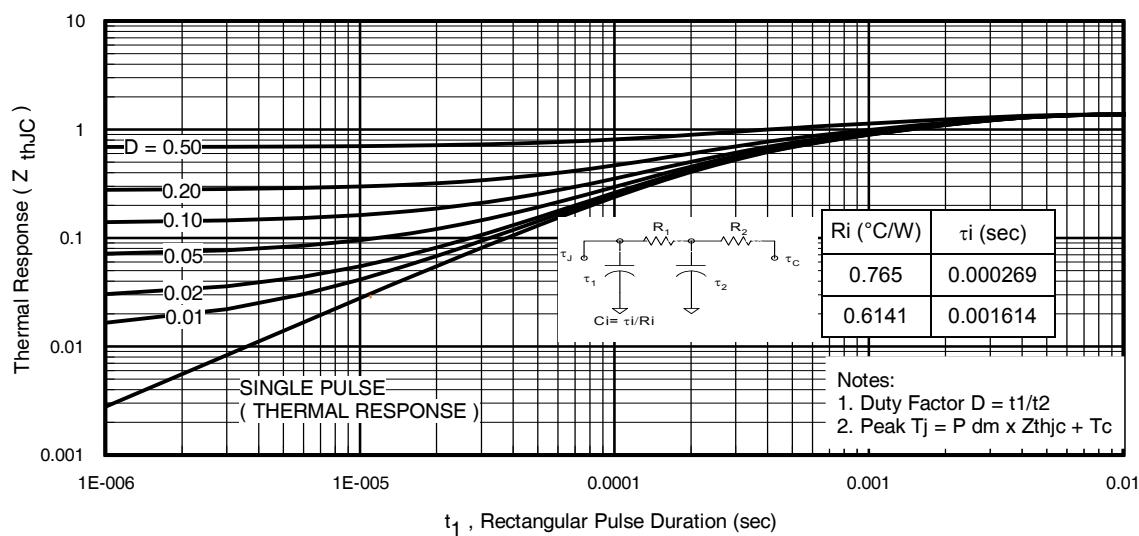


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

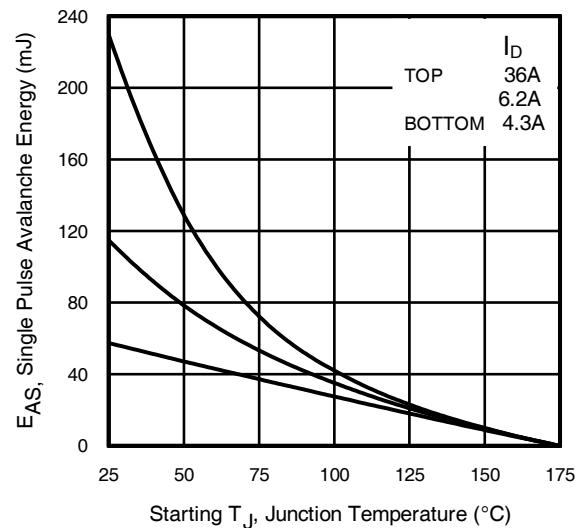
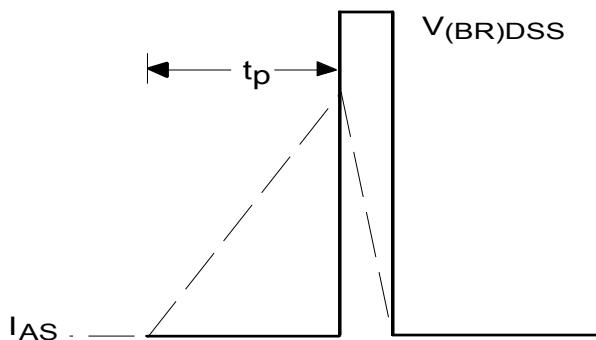
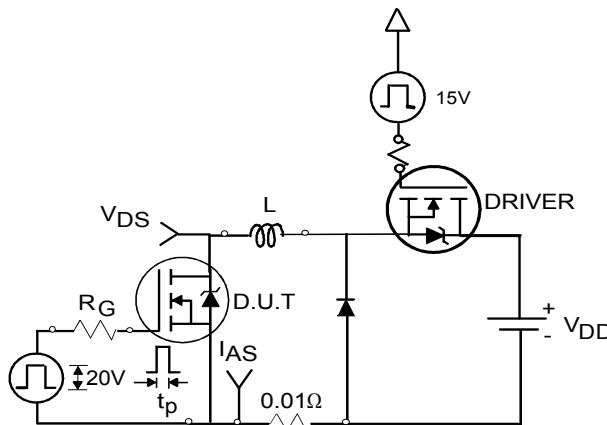


Fig 12c. Maximum Avalanche Energy vs. Drain Current

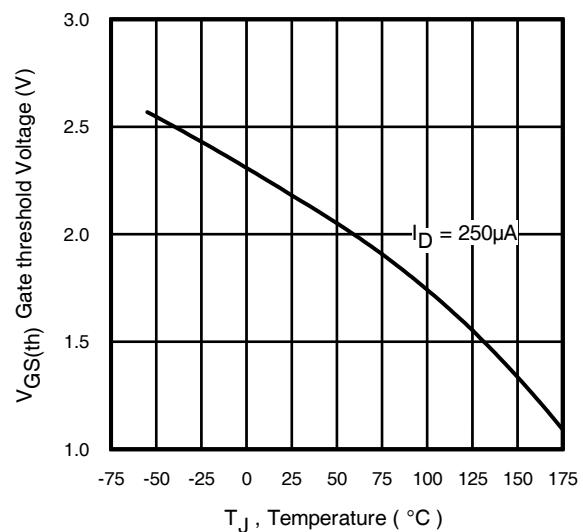
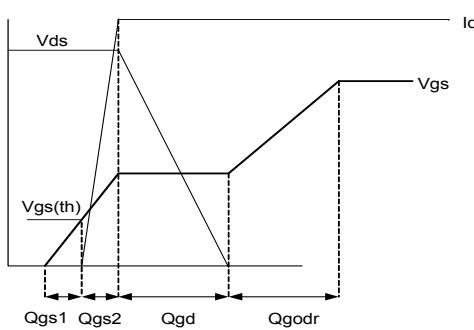
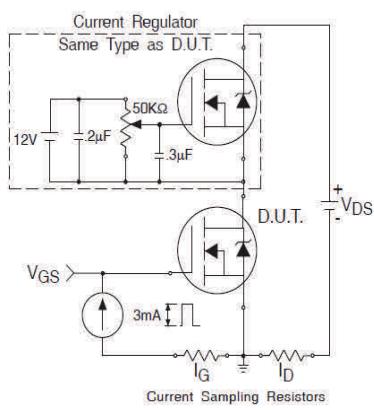


Fig 14. Threshold Voltage Vs. Temperature



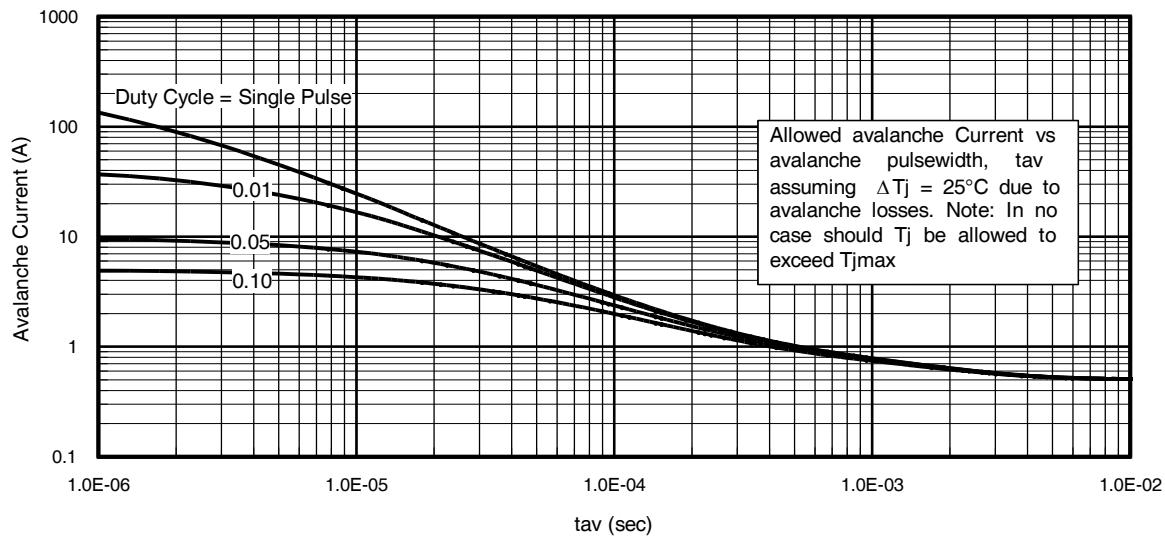


Fig 15. Typical Avalanche Current Vs. Pulse width

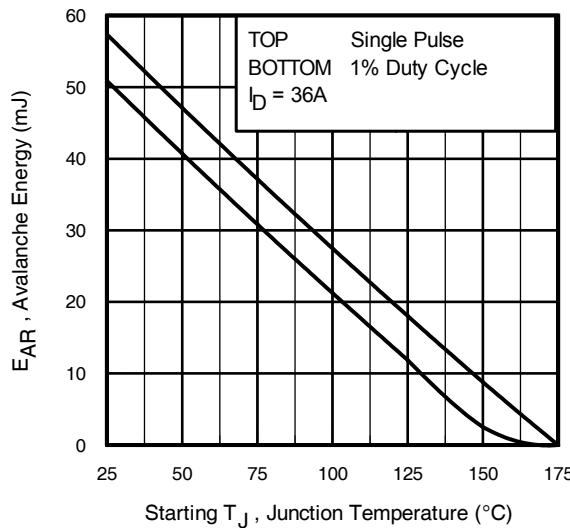


Fig 16. Maximum Avalanche Energy Vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

1. Avalanche failures assumption:
Purely a thermal phenomenon and failure occurs at a temperature far in excess of $T_{j\max}$. This is validated for every part type.
 2. Safe operation in Avalanche is allowed as long as $T_{j\max}$ is not exceeded.
 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
 4. $P_D(\text{ave})$ = Average power dissipation per single avalanche pulse.
 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
 6. I_{av} = Allowable avalanche current.
 7. ΔT = Allowable rise in junction temperature, not to exceed $T_{j\max}$ (assumed as 25°C in Figure 15, 16).
- t_{av} = Average time in avalanche.
 D = Duty cycle in avalanche = $t_{av} \cdot f$
 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13)

$$P_{D(\text{ave})} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(\text{ave})} \cdot t_{av}$$

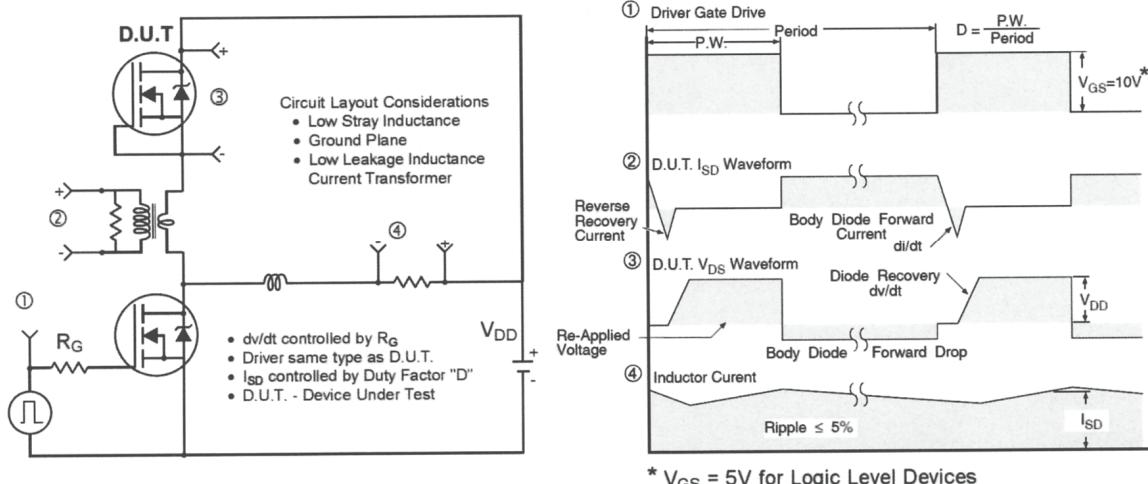


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

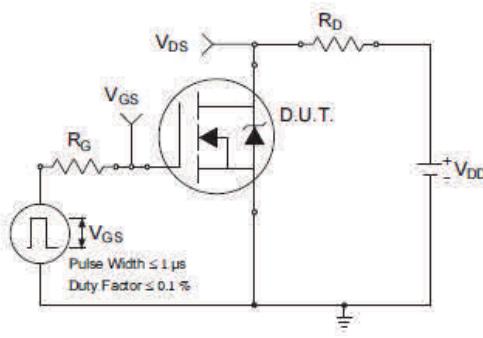


Fig 18a. Switching Time Test Circuit

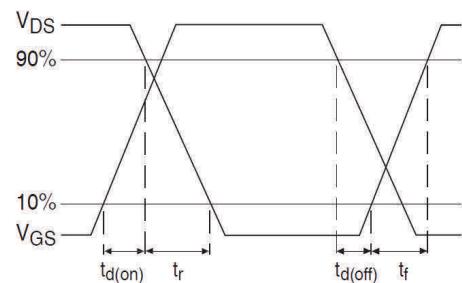
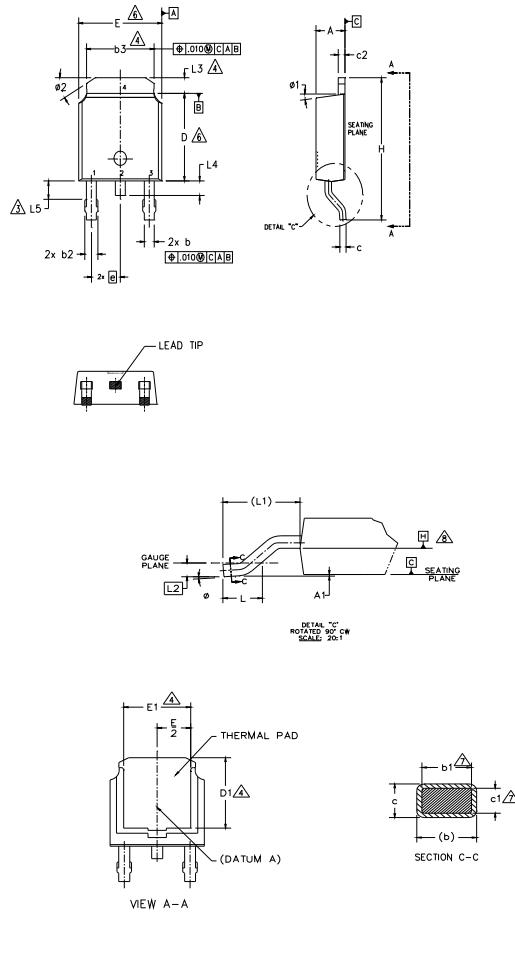


Fig 18b. Switching Time Waveforms

D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))

NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- 3.- LEAD DIMENSION UNCONTROLLED IN L5.
- 4.- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- 6.- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 7.- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- 8.- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

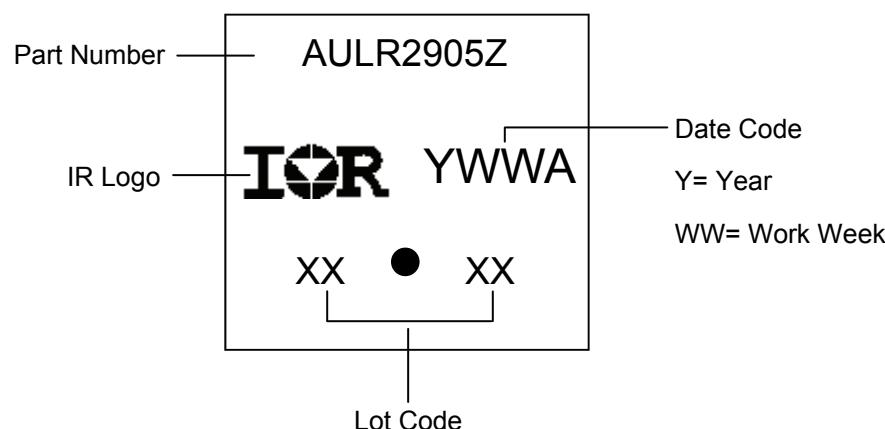
| S Y M B O L | DIMENSIONS | | | | N O T E S | |
|----------------------------|-------------|-------|--------|------|-----------------------|--|
| | MILLIMETERS | | INCHES | | | |
| | MIN. | MAX. | MIN. | MAX. | | |
| A | 2.18 | 2.39 | .086 | .094 | | |
| A1 | — | 0.13 | — | .005 | | |
| b | 0.64 | 0.89 | .025 | .035 | | |
| b1 | 0.65 | 0.79 | .025 | .031 | 7 | |
| b2 | 0.76 | 1.14 | .030 | .045 | | |
| b3 | 4.95 | 5.46 | .195 | .215 | 4 | |
| c | 0.46 | 0.61 | .018 | .024 | | |
| c1 | 0.41 | 0.56 | .016 | .022 | 7 | |
| c2 | 0.46 | 0.89 | .018 | .035 | | |
| D | 5.97 | 6.22 | .235 | .245 | 6 | |
| D1 | 5.21 | — | .205 | — | 4 | |
| E | 6.35 | 6.73 | .250 | .265 | 6 | |
| E1 | 4.32 | — | .170 | — | 4 | |
| e | 2.29 | BSC | .090 | BSC | | |
| H | 9.40 | 10.41 | .370 | .410 | | |
| L | 1.40 | 1.78 | .055 | .070 | | |
| L1 | 2.74 | BSC | .108 | REF. | | |
| L2 | 0.51 | BSC | .020 | BSC | | |
| L3 | 0.89 | 1.27 | .035 | .050 | 4 | |
| L4 | — | 1.02 | — | .040 | | |
| L5 | 1.14 | 1.52 | .045 | .060 | 3 | |
| Ø | 0° | 10° | 0° | 10° | | |
| Ø1 | 0° | 15° | 0° | 15° | | |
| Ø2 | 25° | 35° | 25° | 35° | | |

LEAD ASSIGNMENTSHEXFET

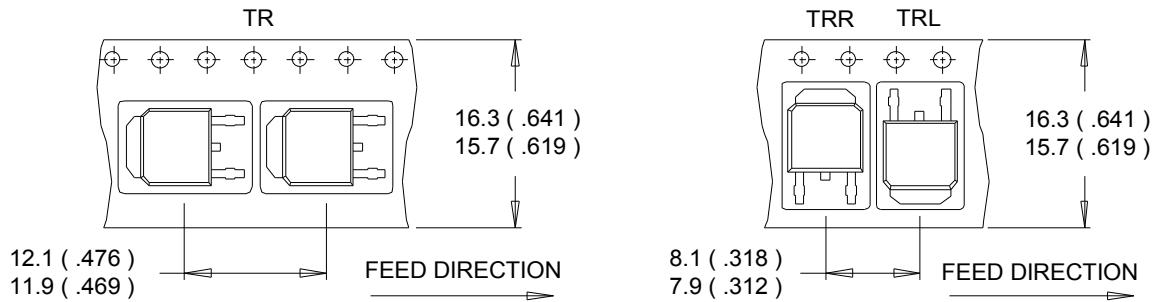
- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

IGBT & CoPAK

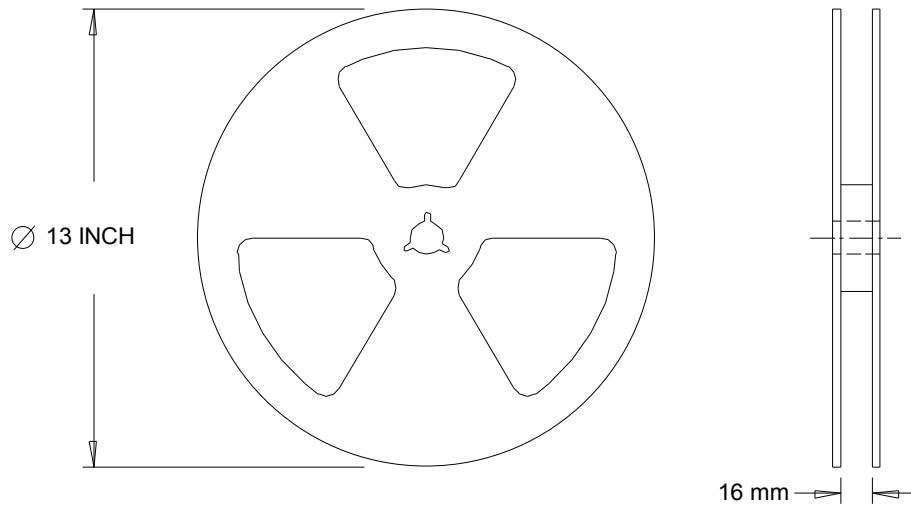
- 1.- GATE
- 2.- COLLECTOR
- 3.- Emitter
- 4.- COLLECTOR

D-Pak (TO-252AA) Part Marking Information

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))**NOTES :**

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.

**NOTES :**

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Qualification Information

| | | | |
|-----------------------------------|----------------------|---|------|
| Qualification Level | | Automotive (per AEC-Q101) | |
| | | Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level. | |
| Moisture Sensitivity Level | | D-Pak | MSL1 |
| ESD | Machine Model | Class M2 (+/- 200V) [†] AEC-Q101-002 | |
| | Human Body Model | Class H1B (+/-1000V) [†] AEC-Q101-001 | |
| | Charged Device Model | Class C5 (+/-1125V) [†] AEC-Q101-005 | |
| RoHS Compliant | | Yes | |

[†] Highest passing voltage.

Revision History

| Date | Comments |
|------------|--|
| 12/11/2015 | <ul style="list-style-type: none"> • Updated datasheet with corporate template • Corrected ordering table on page 1. • Corrected typo R_{0JA} (PCB mount) from "40°C/W" to "50°C/W" on page 1. |

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